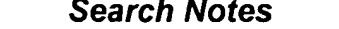


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/705,899	LEE ET AL.	
	Examiner HOAN C. NGUYEN	Art Unit 2871	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner